

Notice of References Cited	Application/Control No. 10/675,797	Applicant(s)/Patent Under Reexamination NISHIZAWA ET AL.	
	Examiner John P. Sheehan	Art Unit 1742	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	C	US-2002/0007875	01-2002	Yamamoto et al.	148/302
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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